New Product



SiE836DF

RoHS

COMPLIANT

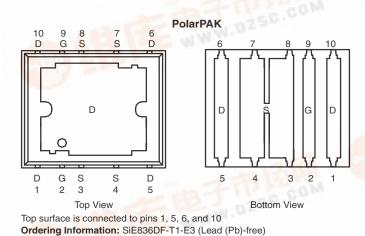
HALOGEN

Vishay Siliconix

N-Channel 200-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
200	0.130 at V _{GS} = 10 V	18.3	27 nC		

Package Drawing www.vishay.com/doc?68798



SiE836DF-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
 - TrenchFET[®] Power MOSFET
- Ultra Low Thermal Resistance Using Top-Exposed PolarPAK[®] Package for Double-Sided Cooling
- Leadframe-Based New Encapsulated Package
- Die Not Exposed
- Low Q_{gd}/Q_{gs} Ratio Helps Prevent Shoot-Through

G

- 100 % R_a and UIS Tested
- Compliant to RoHS directive 2002/95/EC

APPLICATIONS

Primary Side Switch

N-Channel MOSFET For Related Documents www.vishay.com/ppg?68742

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Parameter		Symbol	Limit D150	Unit	
Drain-Source Voltage		V _{DS}	200	v	
Gate-Source Voltage		V _{GS}	± 30	v	
	T _C = 25 °C	9 W(P	18.3		
Continuous Drain Current ($T_1 = 150 \text{ °C}$)	T _C = 70 °C		14.6		
Continuous Drain Current (1) = 150°C)	T _A = 25 °C	I _D	4.1 ^{b, c}		
	T _A = 70 °C		3.3 ^{b, c}		
Pulsed Drain Current		I _{DM}	15	A	
Continuous Course Prain Diada Current	$T_{C} = 25 °C$ $T_{A} = 25 °C$ I_{S}		14.6 ^a		
Continuous Source-Drain Diode Current		I _S	4.3 ^{b, c}	53	
Single Pulse Avalanche Current L = 0.1 mH Avalanche Energy L = 0.1 mH		I _{AS}	5		
		E _{AS}	1.25	mJ	
	T _C = 25 °C		104		
Mauinum Dauran Diagingtian	T _C = 70 °C	D	66		
Maximum Power Dissipation	T _A = 25 °C	P _D	5.2 ^{b, c}	W	
	T _A = 70 °C	SN(6 53)	3.3 ^{b, c}	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}		~	260		

Notes:

a. T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. See Solder Profile (<u>www.vishay.com/doc?73257</u>). The PolarPAK is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.



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THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	20	24	
Maximum Junction-to-Case (Drain Top) ^a	Steady State	R _{thJC} (Drain)	1	1.2	°C/W
Maximum Junction-to-Case (Source) ^{a, c}	Sleady State	R _{thJC} (Source)	2.8	3.4	

Notes:

a. Surface Mounted on 1" x 1" FR4 board.

b. Maximum under Steady State conditions is 68 °C/W.

c. Measured at source pin (on the side of the package).

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•		•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	200			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		7		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 10			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2.5		4.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 30 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		V_{DS} = 200 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	15			A	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.1 \text{ A}$		0.105	0.130	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 4.1 A		14		S	
Dynamic ^b						•	
Input Capacitance	C _{iss}			1200		pF	
Output Capacitance	C _{oss}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		70			
Reverse Transfer Capacitance	C _{rss}			35			
Total Gate Charge	Qg			27	41	nC	
Gate-Source Charge	Q _{gs}	V_{DS} = 100 V, V_{GS} = 10 V, I_{D} = 4.1 A		7			
Gate-Drain Charge	Q _{gd}			10			
Gate Resistance	Rg	f = 1 MHz		1.0	2	Ω	
Turn-On Delay Time	t _{d(on)}			15	25		
Rise Time	t _r	V_{DD} = 100 V, R_L = 30 Ω		10	15	ns	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 3.3 A, V_GEN = 10 V, R_g = 1 Ω		20	30		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristic	s		•		•	•	
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			18.3	A	
Pulse Diode Forward Current ^a	I _{SM}				15		
Body Diode Voltage	V _{SD}	I _S = 3.3 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			90	135	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 3.3 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		270	405	nC	
Reverse Recovery Fall Time	t _a	$r_F = 3.5 \text{ A}, \text{ ui/ut} = 100 \text{ A/}\mu\text{s}, 1\text{ J} = 25 \text{ °C}$		53		ns	
Reverse Recovery Rise Time	t _b			37			

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

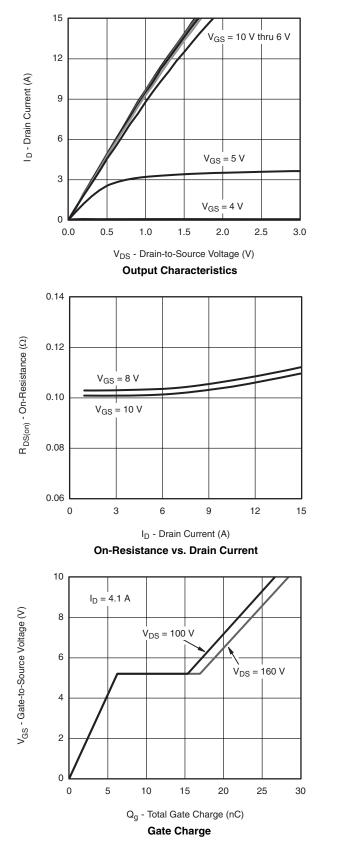
b. Guaranteed by design, not subject to production testing.

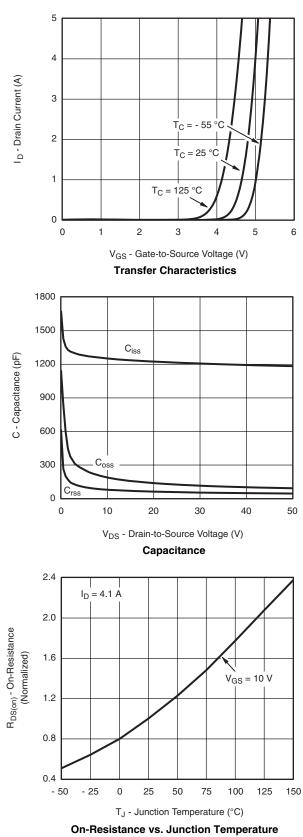
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



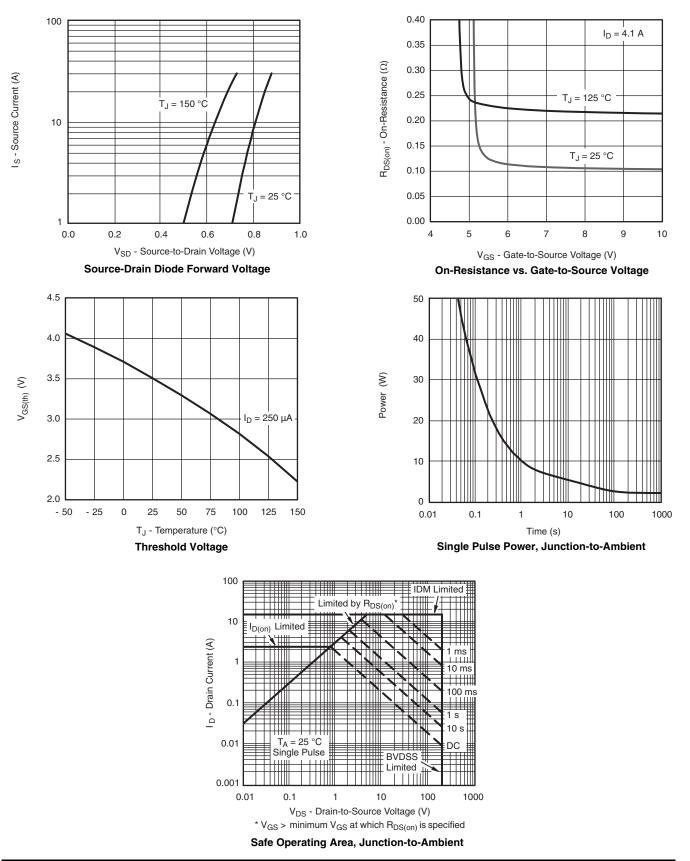


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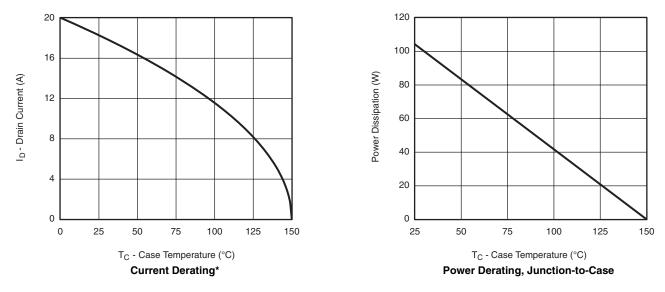
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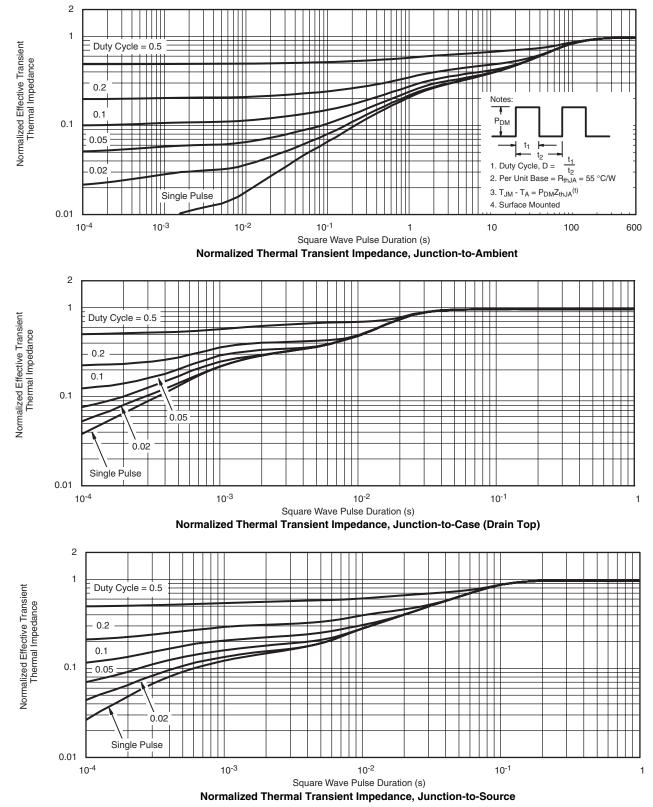


* The power dissipation P_D is based on $T_{J(max)} = 150 \text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68742.



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